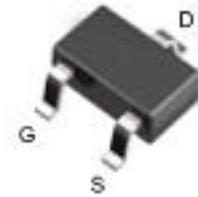


N-Channel Enhancement Mode MOSFET

Features

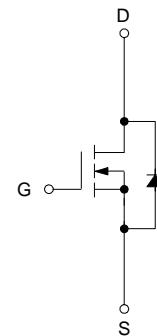
- +30V / 4A , N-MOSFET
 $R_{DS(ON)}=30m\Omega$ (typ.) @ $V_{GS}=10V$
 $R_{DS(ON)}=50m\Omega$ (typ.) @ $V_{GS}=4.5V$
- Super High Dense Cell Design
- Reliable and Rugged
- Lead Free Available (RoHS Compliant)

Pin Description

Top View of SOT-23

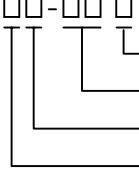
Applications

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.



N-Channel MOSFET

Ordering and Marking Information

BM3406  Lead Free Code Handling Code Temp. Range Package Code	Package Code A : SOT-23 Operating Junction Temp. Range C : -55 to 150°C Handling Code TU : Tube TR : Tape & Reel Lead Free Code L : Lead Free Device Blank : Original Device
	

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter		Rating	Unit
V_{DSS}	Drain-Source Voltage		30	V
V_{GSS}	Gate-Source Voltage		± 20	
I_D^*	Continuous Drain Current		4.0	A
I_{DM}^*	$300\mu\text{s}$ Pulsed Drain Current		12	
I_S^*	Diode Continuous Forward Current		1.3	A
T_J	Maximum Junction Temperature		150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range		-55 to 150	
P_D^*	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	0.83	W
		$T_A=100^\circ\text{C}$	0.3	
$R_{\theta JA}^*$	Thermal Resistance-Junction to Ambient		150	$^\circ\text{C}/\text{W}$

Note:

*Surface Mounted on 1in² pad area, $t \leq 10\text{sec}$.

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	BM3406			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$	30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$			1	μA
		$T_J=85^\circ\text{C}$			30	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$	1	1.5	2	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$			± 100	nA
$R_{DS(ON)}^a$	Drain-Source On-state Resistance	$V_{GS}=10\text{V}, I_{DS}=4\text{A}$		30	45	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_{DS}=2.8\text{A}$			55	
V_{SD}^a	Diode Forward Voltage	$I_{SD}=1.25\text{A}, V_{GS}=0\text{V}$		0.8	1.3	V
Gate Charge Characteristics^b						
Q_g	Total Gate Charge	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, I_{DS}=4\text{A}$		12.5	16	nC
Q_{gs}	Gate-Source Charge			2.4		
Q_{gd}	Gate-Drain Charge			1.3		

Electrical Characteristics (Cont.) ($T_A = 25^\circ\text{C}$ unless otherwise noted)

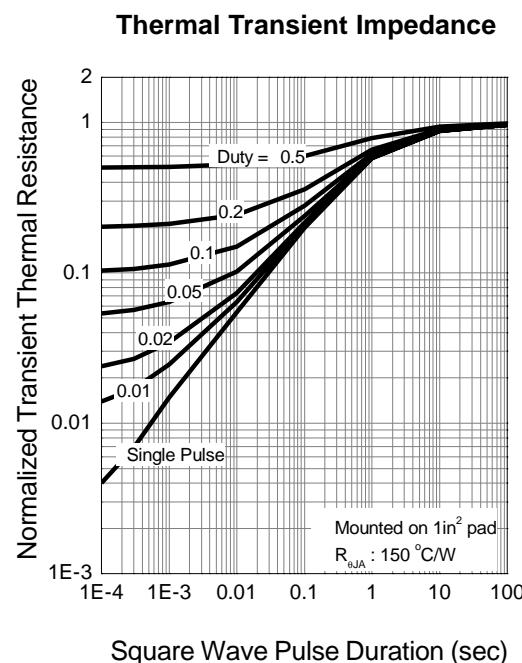
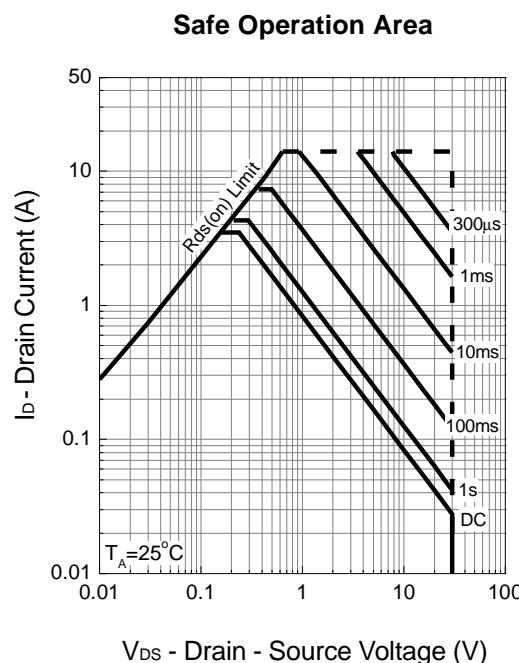
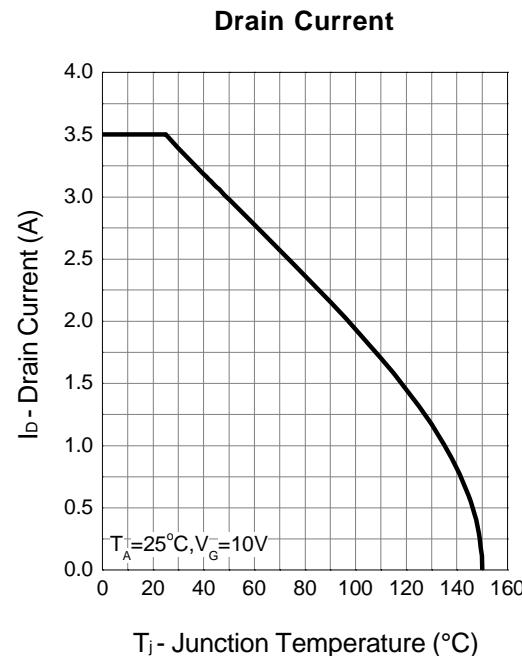
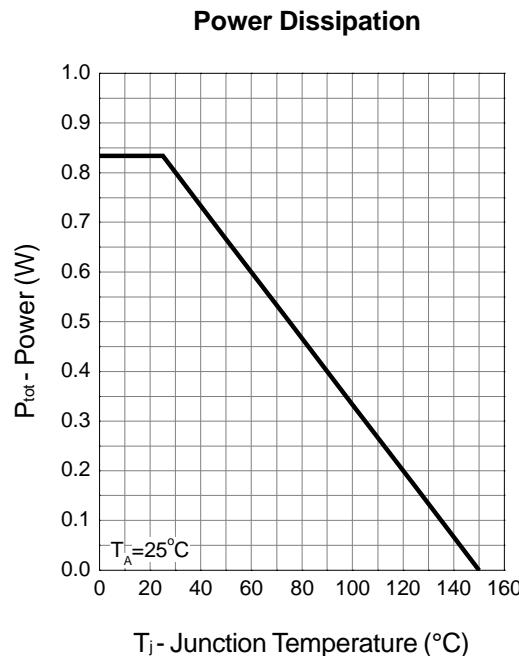
Symbol	Parameter	Test Condition	BM3406			Unit
			Min.	Typ.	Max.	
Dynamic Characteristics^b						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		1.5		Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =25V, Frequency=1.0MHz		400		pF
C _{oss}	Output Capacitance			80		
C _{rss}	Reverse Transfer Capacitance			45		
t _{d(ON)}	Turn-on Delay Time	V _{DD} =15V, R _L =15Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω		10	19	ns
T _r	Turn-on Rise Time			8	15	
t _{d(OFF)}	Turn-off Delay Time			19	35	
T _f	Turn-off Fall Time			6.2	12	

Notes:

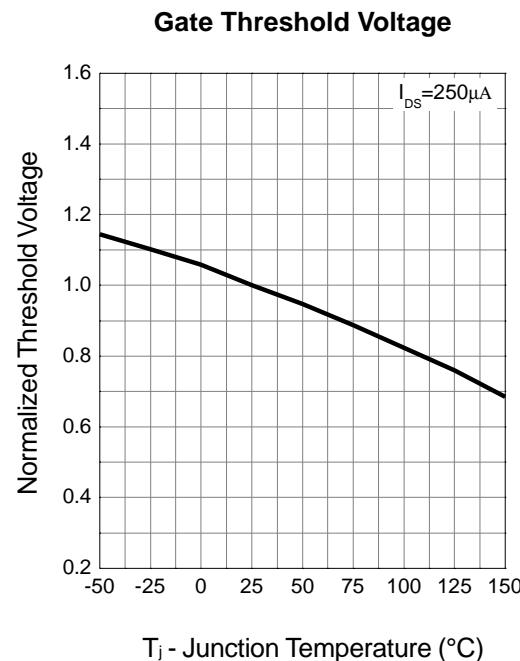
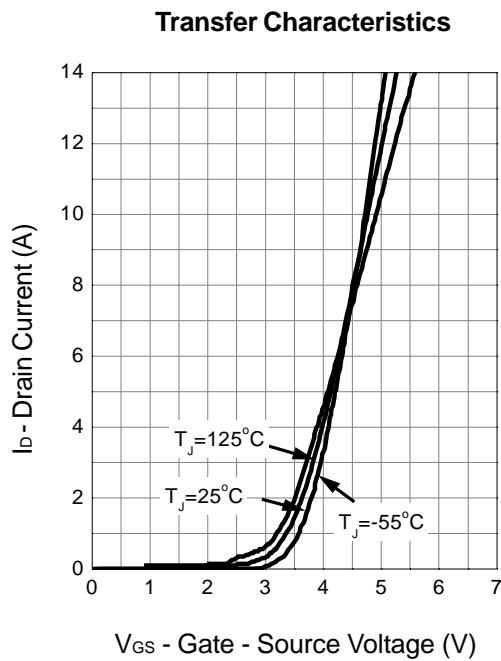
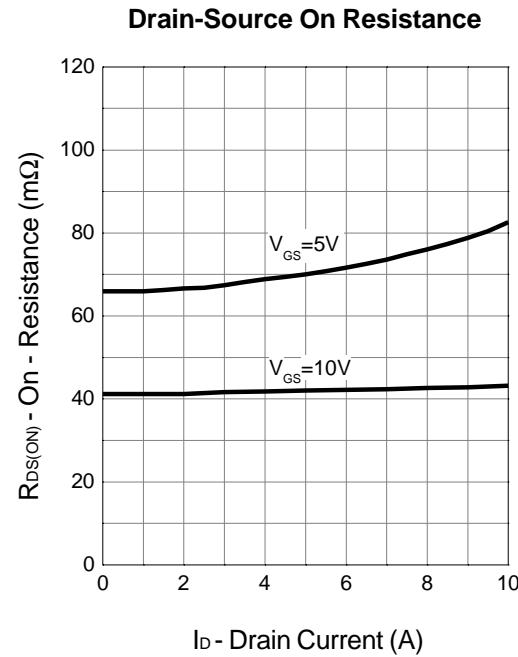
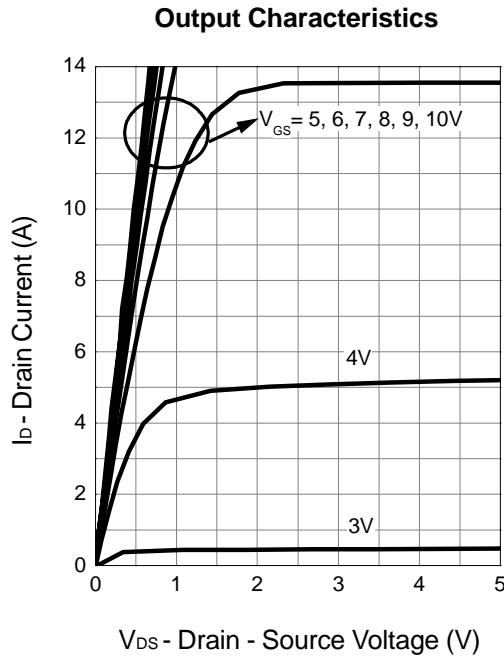
a : Pulse test ; pulse width≤300μs, duty cycle≤2%.

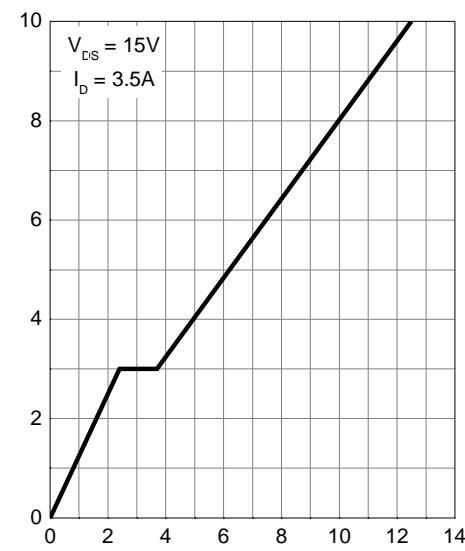
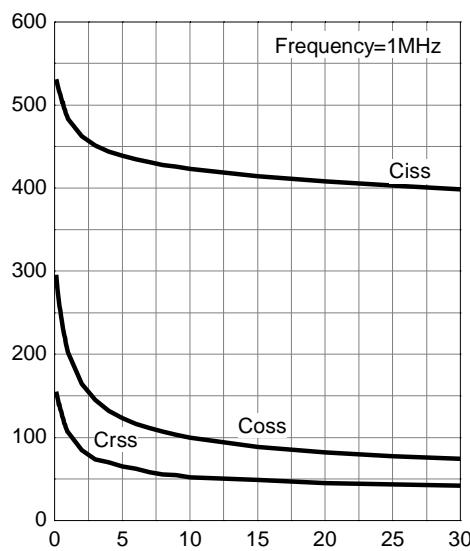
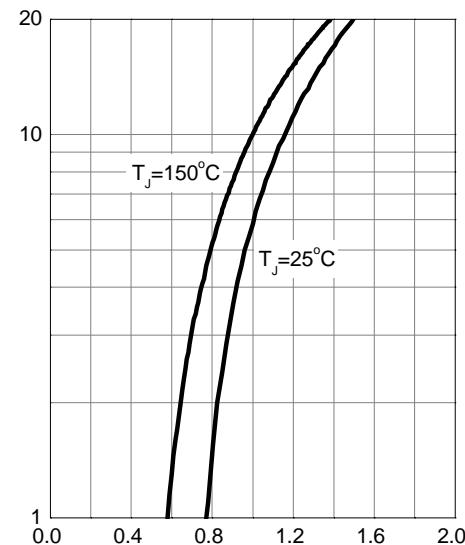
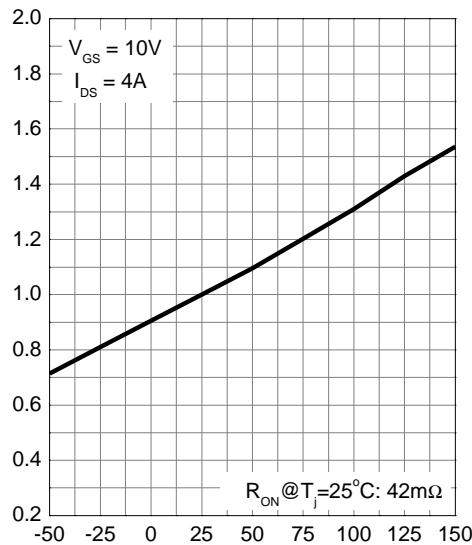
b : Guaranteed by design, not subject to production testing.

Typical Characteristics



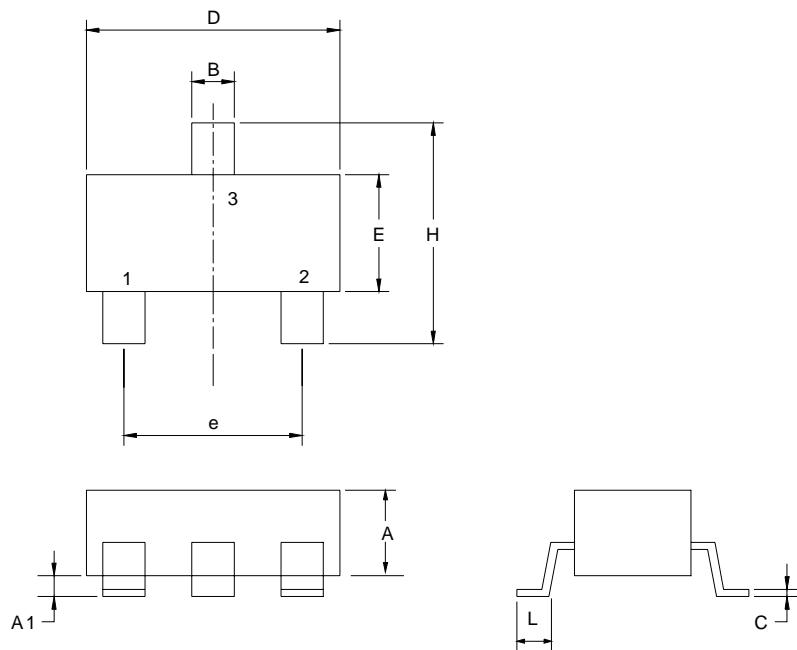
Typical Characteristics (Cont.)





Packaging Information

SOT-23



Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	1.00	1.30	0.039	0.051
A1	0.00	0.10	0.000	0.004
B	0.35	0.51	0.014	0.020
C	0.10	0.25	0.004	0.010
D	2.70	3.10	0.106	0.122
E	1.40	1.80	0.055	0.071
e	1.90/2.1 BSC.		0.075/0.083 BSC.	
H	2.40	3.00	0.094	0.118
L	0.37		0.015	